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Application/Control No.	Applicant(s)/Patent under Reexamination
10/010,657	ALTHIN ET AL.
Examiner	Art Unit
1:b-	0455

	SEAD	CHED	
	JEAN	CHED	
Class	Subclass	Date	Examiner
709	217-219, 224, 227, 229	1/30/2007	LW
707	1, 3	1/30/2007	LW
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated EAST Search: USPAT, USPUB, EPO, JPO, DERWENT	1/30/2007	LW
argument consulted with Eddie Lee, Thu Ha Nguyen	1/30/2007	LW
101 consulted with John Follansbee	1/30/2007	. LW
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